

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 129526		APPLICATION NO. 10/594,061	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANT(S) Yuichi SHIBAZAKI			
				FILING DATE December 22, 2006		GROUP 2851	

  

U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number	Date	Name
	1.	5,448,332	09/05/1995	SAKAKIBARA et al.
	2.	5,243,195	09/07/1993	NISHI
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	4.	4,465,368	08/14/1984	MATSUURA et al.
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	8.	5,646,413	07/08/1997	NISHI
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	11.	4,346,164	08/24/1982	TABARELLI et al.
	12.	4,480,910	11/06/1984	TAKANASHI et al.
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	18.	JP A 2005-129914	05/19/2005	JAPAN	X	X
	19.	JP A 2004-61177	02/26/2004	JAPAN	X	X
	20.	JP A 11-87237	03/30/1999	JAPAN	X	X

  

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Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

  

EXAMINER	DATE CONSIDERED
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